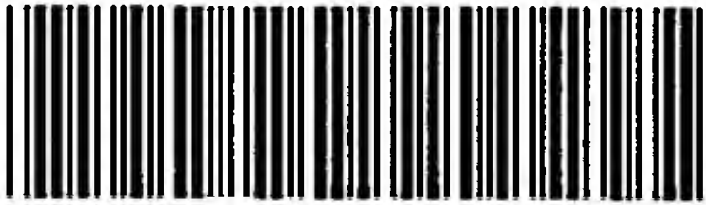


<div>S arch Notes</div> <div></div>	Applicati n/C ntr I N .	Applicant(s)/Pat nt und r Reexaminati n	
	10/708,518	HARPER ET AL.	
	Examiner	Art Unit	
	Hong C. Kim	2185	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	8/1/06	cdh